

# Uniform Direct Product Theorems:

Simplified, Optimized, and Derandomized

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# Direct Product(DP) Theorem

(the general statement)

- "If a problem is a hard to solve on average, then solving multiple instances of the problem is even harder".



# Applications of such Statements

- Average-case Complexity
- Cryptography
- Derandomization
- Error-correcting codes



# Formulating DP Theorems

- “If a problem is a hard to solve on average, then solving multiple instances of the problem is even harder”.
- What is the problem?  
(e.g., computing functions, interactive arguments)
- What is the entity solving the problem?  
(e.g., circuits, randomized algorithms)
- What does it mean by a problem being hard on average?



# A Simple DP Theorem

(boolean functions against circuits)

- Problem: Computing boolean functions
- Computational model: Circuits
- Hardness: A boolean function  $f: \{0,1\}^n \rightarrow \{0,1\}$  is called  $\delta$ -hard for circuits of size  $s$  if for any circuit  $C$  of size at most  $s$ , we have

$$\Pr_x[C(x) \neq f(x)] > \delta$$



# A Simple DP Theorem

(boolean functions against circuits)

- Let  $f:\{0,1\}^n \rightarrow \{0,1\}$  be a boolean function and  $f^k$  defined as

$$f^k(x_1, \dots, x_k) = f(x_1) \cdot f(x_2) \dots f(x_k)$$

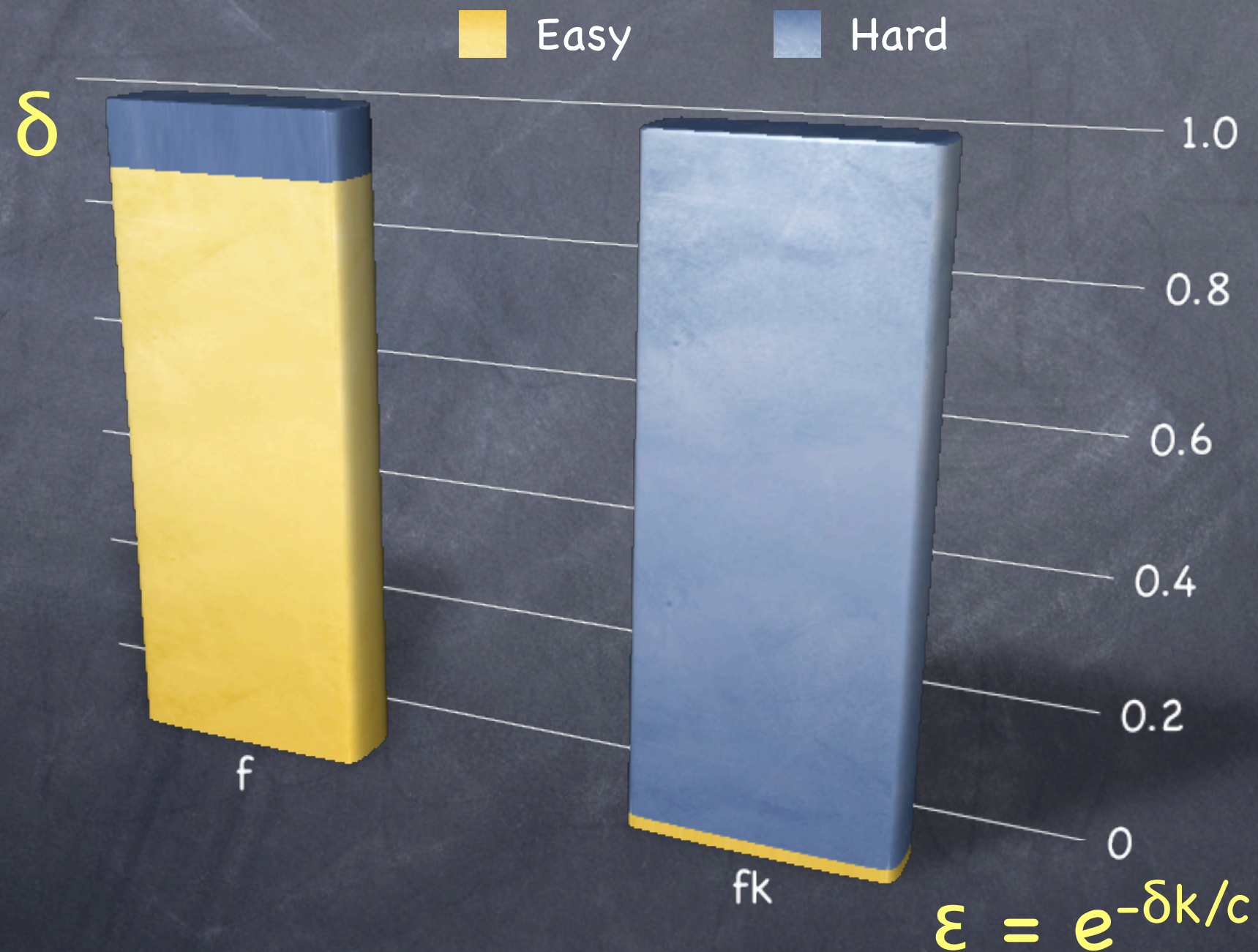
- If  $f$  is  $\delta$ -hard for circuits of size  $s$ , then  $f^k$  is  $(1-\epsilon)$ -hard for circuits of size  $s'$ , where

$$\delta = \Theta(\log(1/\epsilon)/k) \text{ and } s' = s \cdot \text{poly}(\epsilon, \delta, 1/k, 1/n).$$



# A Simple DP Theorem

(boolean functions against circuits)





# A Related XOR Lemma

(boolean functions against circuits)

- Let  $f:\{0,1\}^n \rightarrow \{0,1\}$  be a boolean function and  $f^{\oplus k}$  defined as

$$f^{\oplus k}(x_1, \dots, x_k) = f(x_1) \oplus f(x_2) \oplus \dots \oplus f(x_k)$$

- If  $f$  is  $\delta$ -hard for circuits of size  $s$ , then  $f^{\oplus k}$  is  $(1/2-\epsilon)$ -hard for circuits of size  $s'$ , where

$$\delta = \Theta(\log(1/\epsilon)/k) \text{ and } s' = s \cdot \text{poly}(\epsilon, \delta, 1/k, 1/n).$$



# DP Theorems: A History

(from the perspective of proof idea)

- Levin style Argument [Yao82, Lev87]:
  - Pseudorandom generators
- Impagliazzo's Hard-core set theorem [Imp95]:
  - Hardness of boolean function, Derandomization
- Trust Halving Strategy [IW97, BIN97]:
  - Derandomization, Cryptography



# General Proof Strategy

(proof by contradiction)

- Assume: there exists  $C'$  such that

$$\Pr_{(x_1, \dots, x_k)}[C'(x_1, \dots, x_k) = f^k(x_1, \dots, x_k)] > \varepsilon$$

- Construct: a circuit  $C$  such that

$$\Pr_x[C(x) = f(x)] > (1 - \delta)$$



# General Proof Strategy

(proof by contradiction)

- Bottleneck: there can possibly exist  $f_1, \dots, f_T$  ( $T = 1/\varepsilon$ ) such that for all  $i \in [T]$

$$\Pr_{(x_1, \dots, x_k)}[C'(x_1, \dots, x_k) = f_i^k(x_1, \dots, x_k)] > \varepsilon$$



# General Proof Strategy

(proof by contradiction)

- Assume: there exists  $C'$  such that

$$\Pr_{(x_1, \dots, x_k)}[C'(x_1, \dots, x_k) = f^k(x_1, \dots, x_k)] > \varepsilon$$

- Construct: a list of circuit  $C_1, \dots, C_T$  such that there exists  $i \in [T]$  such that

$$\Pr_x[C_i(x) = f(x)] > (1 - \delta)$$

How large could  $T$  be?



# Nonuniformity in DP Theorems

- A string of length  $\log(T)$  can be used to point out the correct circuit in the list.
- Generalize the results to general functions  $f:\{0,1\}^* \rightarrow \{0,1\}$  w.r.t. randomized algorithms with advice (nonuniform model)
- A strong DP Theorem in the uniform model is not possible
- Uniform DP Theorem: A DP theorem with “minimum amount of nonuniformity”



# DP Theorem

(a coding theoretic perspective)

- Direct Product code:

- Let  $N = 2^n$ ,  $\Sigma = \{0,1\}^k$ ,  $M = N^k$

- Message:  $m \in \{0,1\}^N$

- Code:  $\text{Code}: \{0,1\}^N \rightarrow \Sigma^M$  defined as

- let each bit of  $m$  be indexed by  $x \in \{0,1\}^n$   
denoted by  $m[x]$

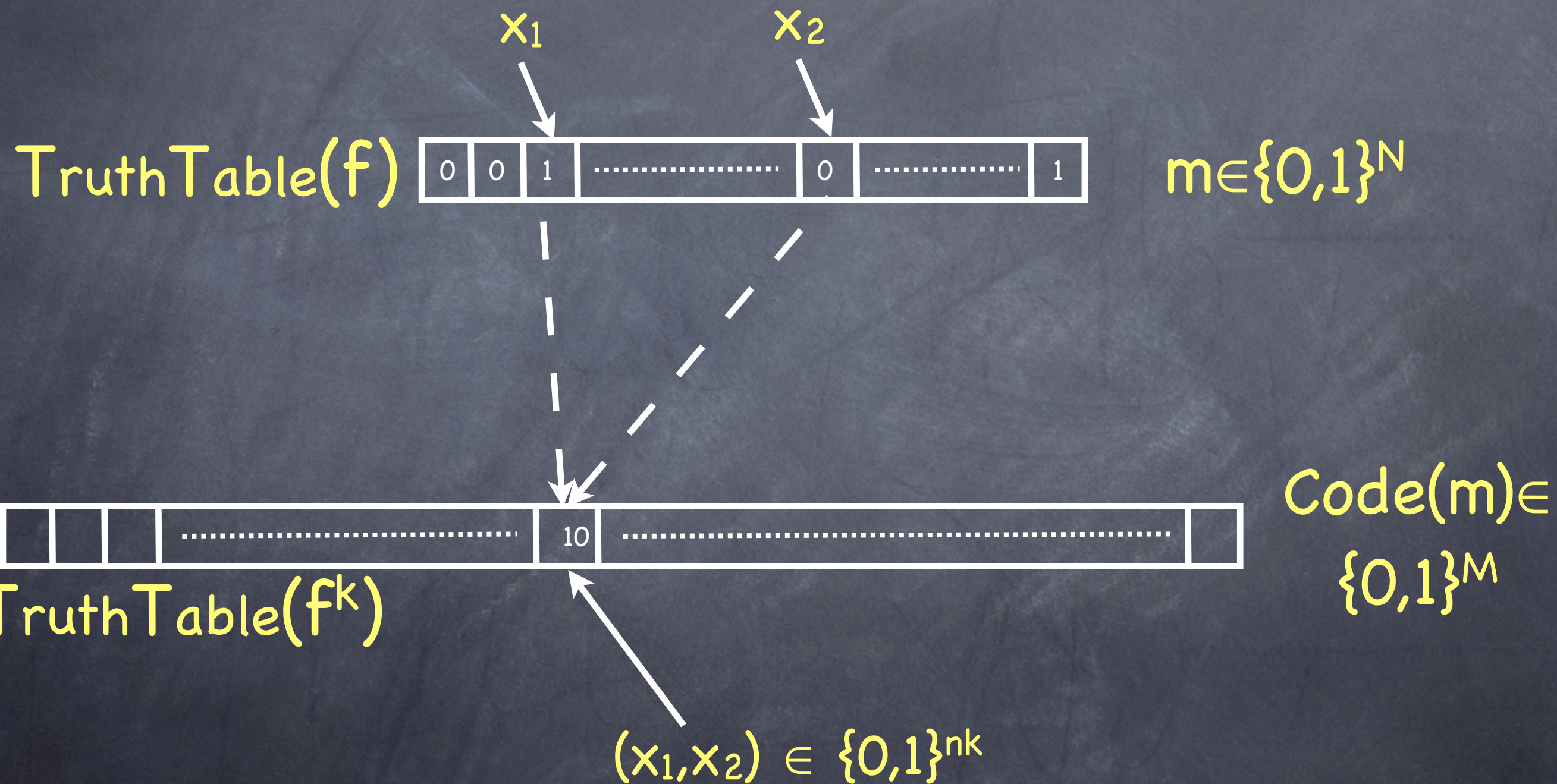
- each alphabet of  $\text{Code}(m)$  can be indexed by  $(x_1, \dots, x_k)$

- $\text{Code}(m)[(x_1, \dots, x_k)] = m[x_1].m[x_2] \dots m[x_k]$



# DP Theorem

(a coding theoretic perspective)

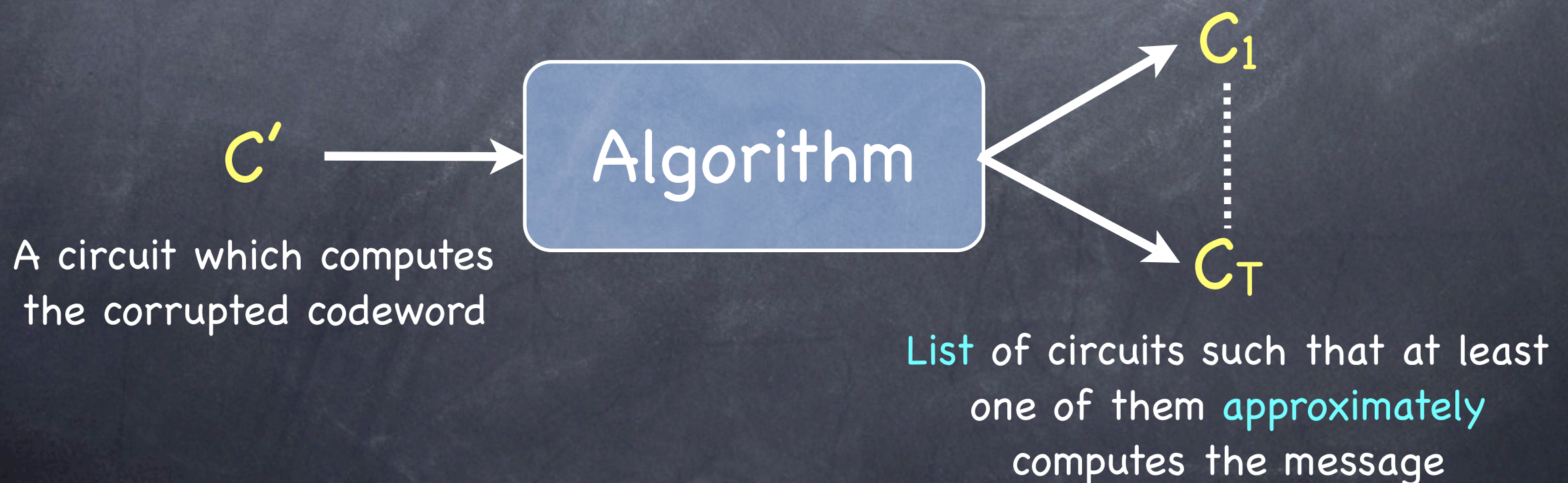




# Connection with DP Theorem

(a coding theoretic perspective)

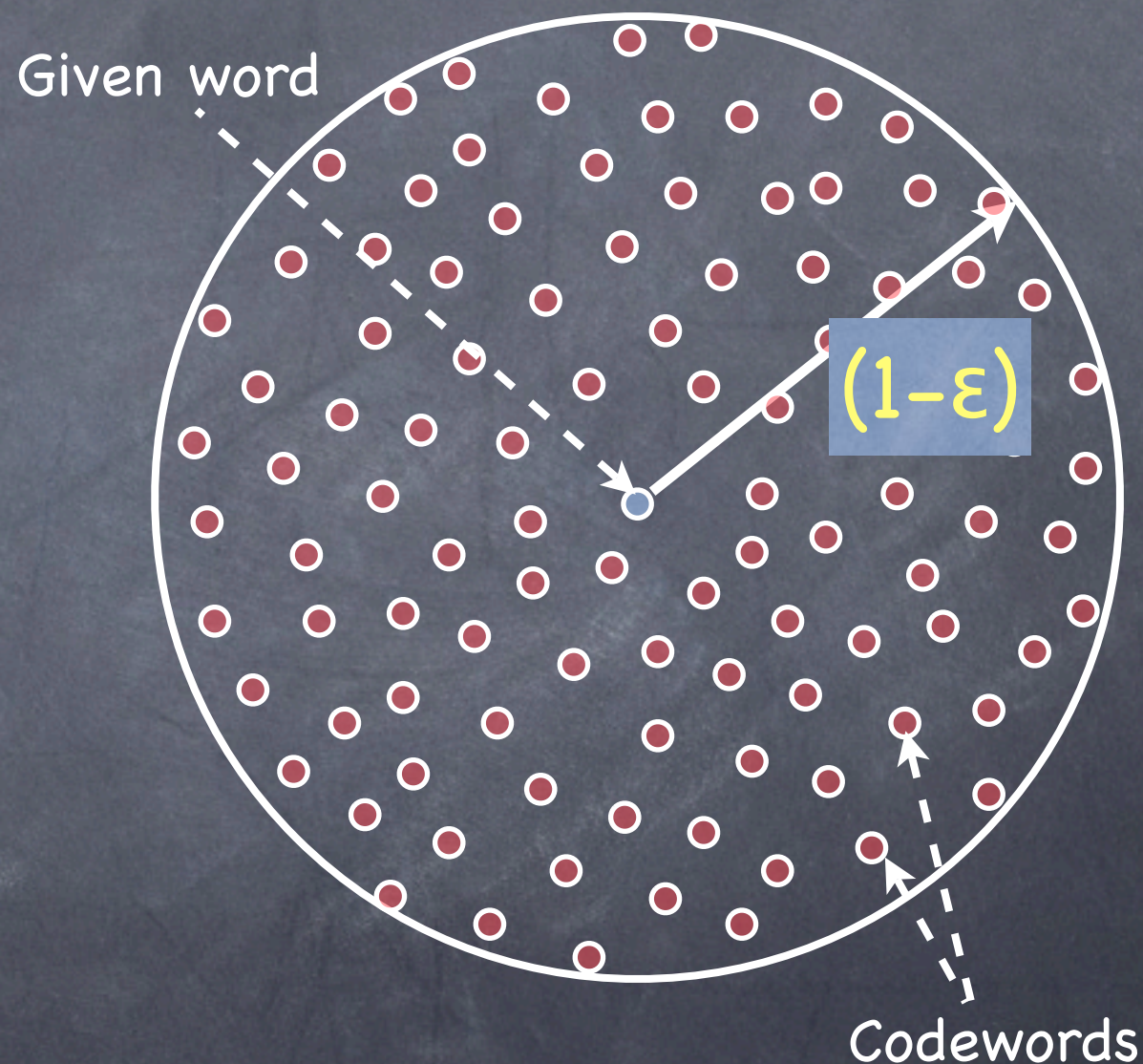
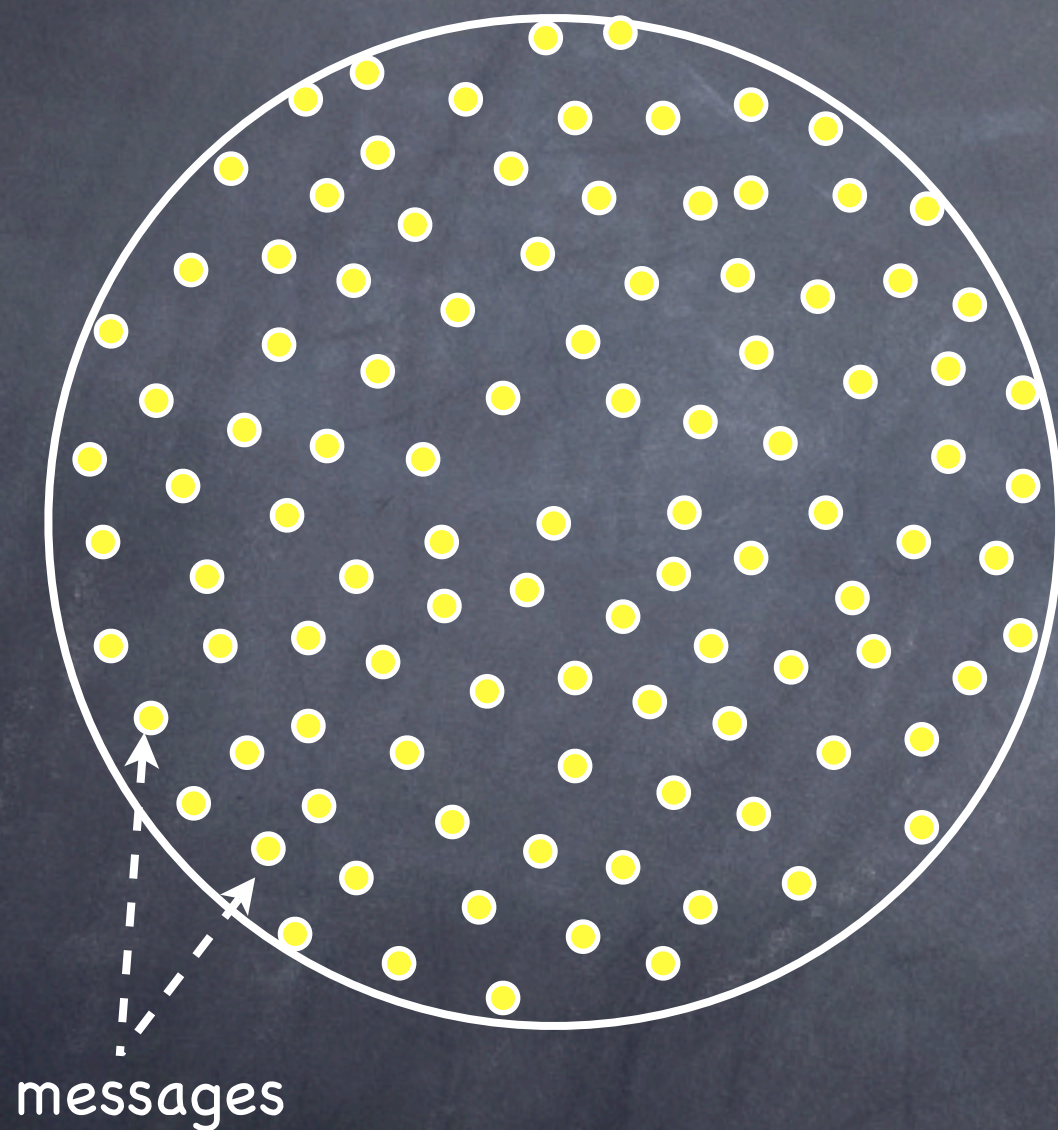
- Any constructive proof of the DP Theorem gives an approximate, local, list decoding algorithm for DP code.





# DP Theorem

(a coding theoretic perspective)

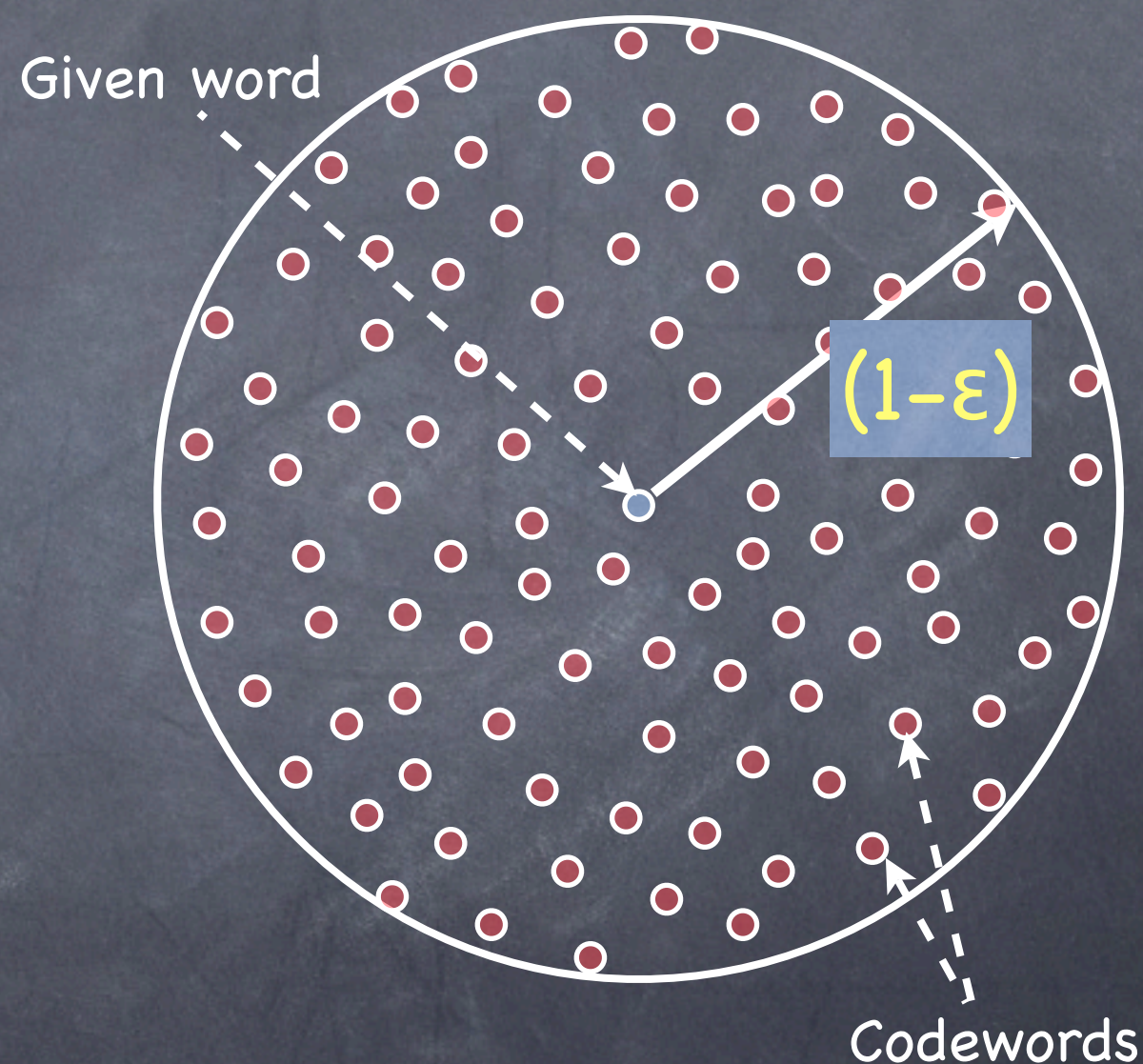
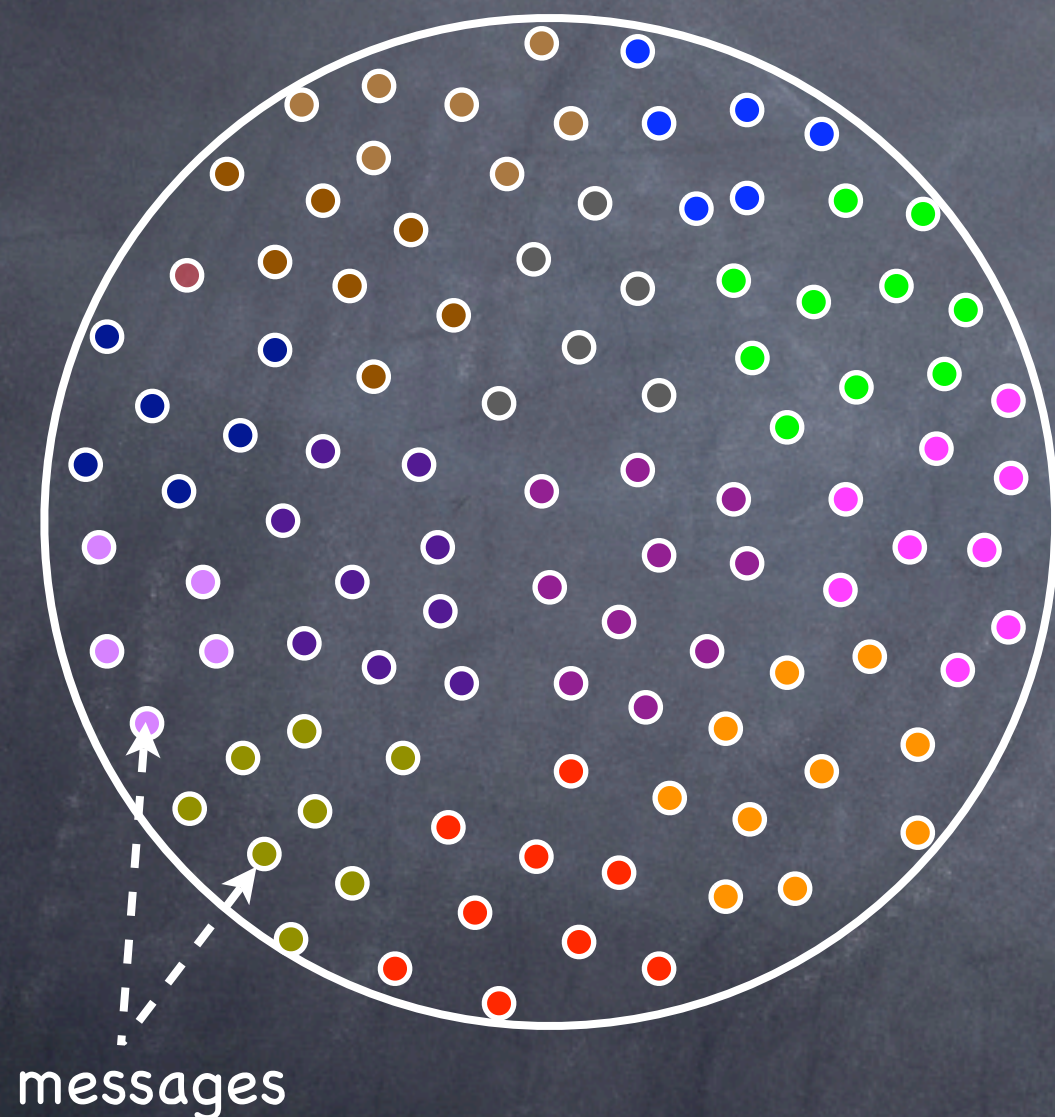


List Decoding



# DP Theorem

(a coding theoretic perspective)



Approximate list decoding



# DP Theorem

(a coding theoretic perspective)

- Let  $\delta = \Theta(\log(1/\varepsilon)/k)$
- For any message  $m$  and its corrupted codeword  $w \in \{0,1\}^N$  such that  $\text{Ham}(\text{Code}(m), w) < (1-\varepsilon) \cdot N$ , then there are  $T = \Theta(1/\varepsilon)$  messages  $m_1, \dots, m_T$  such that for at least one  $m_i$ ,  $\text{Ham}(m_i, m) < \delta \cdot N$



# Bounds for the Related XOR Code

- Let  $\delta = \Theta(\log(1/\varepsilon)/k)$
- Given a message  $m$  and its corrupted codeword  $w \in \{0,1\}^N$  such that  $\text{Ham}(\text{XOR-Code}(m), w) < (1/2 - \varepsilon) \cdot M$ , then there are  $T = \Theta(1/\varepsilon^2)$  messages  $m_1, \dots, m_T$  such that for at least one  $m_i$ ,  $\text{Ham}(m_i, m) < \delta \cdot N$



# DP Theorem

(a coding theoretic perspective)

- All previous proofs [Lev87, Imp95, IW97...] of the DP theorem gave list size  $2^{\text{poly}(1/\epsilon)}$ .
- [IJK06, IJKW08]: List decoding algorithm with size  $\Theta(1/\epsilon)$  which is information theoretically optimal.



# Uniform DP Theorem

(the first attempt)

- Main Theorem [IJK06]: Let  $f:U \rightarrow \{0,1\}$  be some function and  $C'$  be a circuit such that  $\Pr[C' \text{ computes } f^k] > \epsilon$ .  
There is an algorithm which outputs a list of circuits  $C_1, \dots, C_T$  such that  $\exists i, \Pr[C_i \text{ computes } f] > (1-\delta)$ , where  $\epsilon = \text{poly}(1/k)$ ,  $\forall i, |C_i| = |C'| \cdot \text{poly}(1/\epsilon, 1/\delta, k)$ ,  $T = \text{poly}(1/\epsilon)$ .
- Drawbacks:
  - Worked for large  $\epsilon$ .
  - Complicated algorithm and analysis.



# Uniform DP Theorem

(the final attempt)

- Main Theorem [IJKW08]: Let  $f:U \rightarrow R$  be some function and  $C'$  be a circuit such that  $\Pr[C' \text{ computes } f^k] > \varepsilon$ .  
There is an algorithm which outputs a list of circuits  $C_1, \dots, C_T$  such that  $\exists i, \Pr[C_i \text{ computes } f] > (1-\delta)$ , where  $\delta = \Theta(\log(1/\varepsilon)/k)$ ,  $\forall i, |C_i| = |C'| \cdot \text{poly}(1/\varepsilon, 1/\delta, k)$ ,  $T = O(1/\varepsilon)$ .



# Uniform XOR Lemma

- Theorem [IJKW08]: Let  $f:U \rightarrow \{0,1\}$  be some function and  $C'$  be a circuit such that  $\Pr[C' \text{ computes } f^{\oplus k}] > 1/2 + \varepsilon$ .  
There is an algorithm which outputs a list of circuits  $C_1, \dots, C_T$  such that  $\exists i, \Pr[C_i \text{ computes } f] > (1-\delta)$ , where  $\delta = \Theta(\log(1/\varepsilon)/k)$ ,  $\forall i, |C_i| = |C'| \cdot \text{poly}(1/\varepsilon, 1/\delta, k)$ ,  $T = O(1/\varepsilon^2)$ .



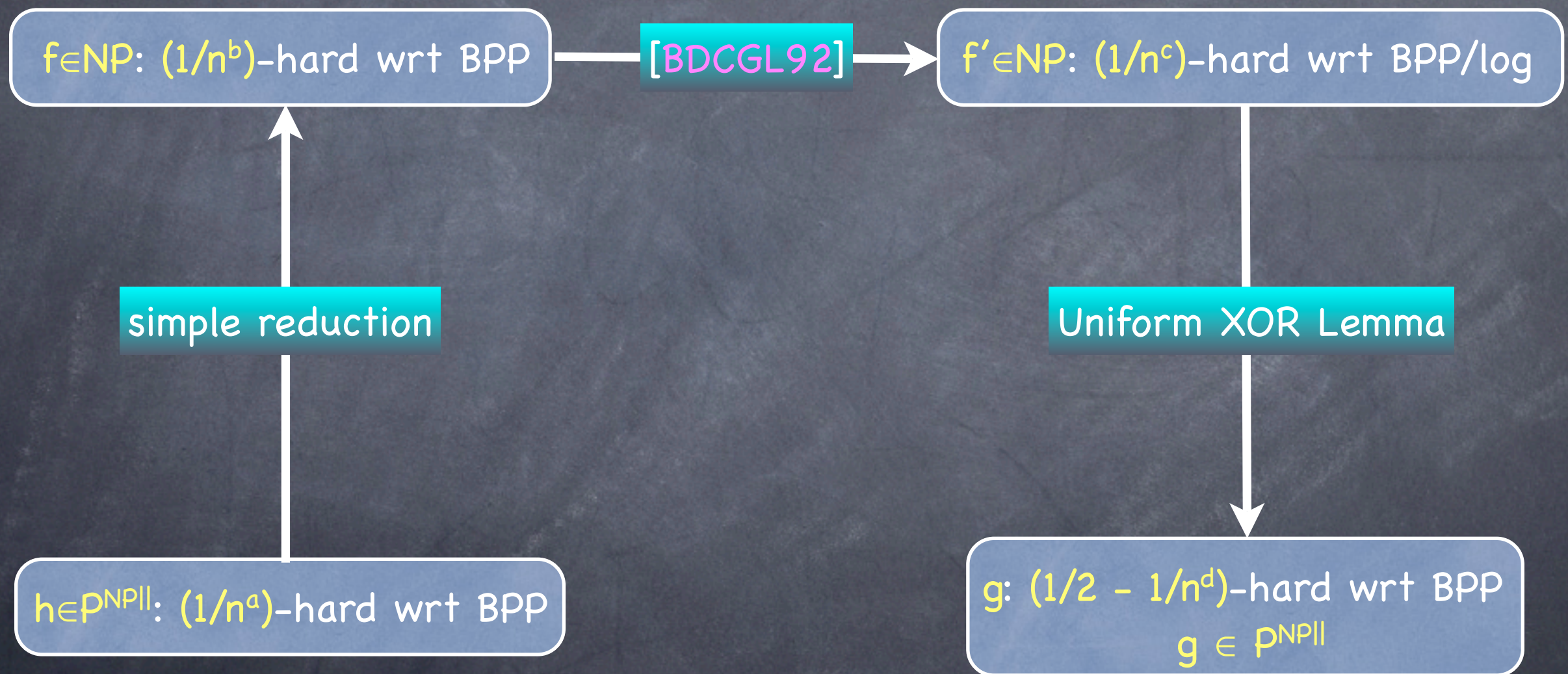
# Uniform Hardness Amplification

- Average-case Complexity: Average-case hardness of problems instead of worst-case.
- Uniform hardness amplification within  $\mathcal{C}$ : If there is a problem within  $\mathcal{C}$  which is mildly hard on average for probabilistic polynomial time algorithms, then is there another problem in  $\mathcal{C}$  which is very hard for probabilistic polynomial time algorithms.



# Uniform Hardness Amplification

(Hardness Amplification within  $P^{NP||}$ )



$P^{NP||}$ : polynomial time turing machine which can make polynomial parallel oracle queries to an  $NP$  oracle.



# Uniform Direct Product Theorem: The Proof



# Main Theorem

- Theorem [IJKW08]: Let  $f:U \rightarrow R$  be some function and  $C'$  be a circuit such that  $\Pr[C' \text{ computes } f^k] > \epsilon$ .  
There is an algorithm which outputs with probability  $\Omega(\epsilon)$  a circuit  $C$  such that  $\Pr[C \text{ computes } f] > (1-\delta)$ ,  
where  $\delta = \Theta(\log(1/\epsilon)/k)$ ,  $|C| = |C'| \cdot \text{poly}(1/\epsilon, 1/\delta, k)$ .

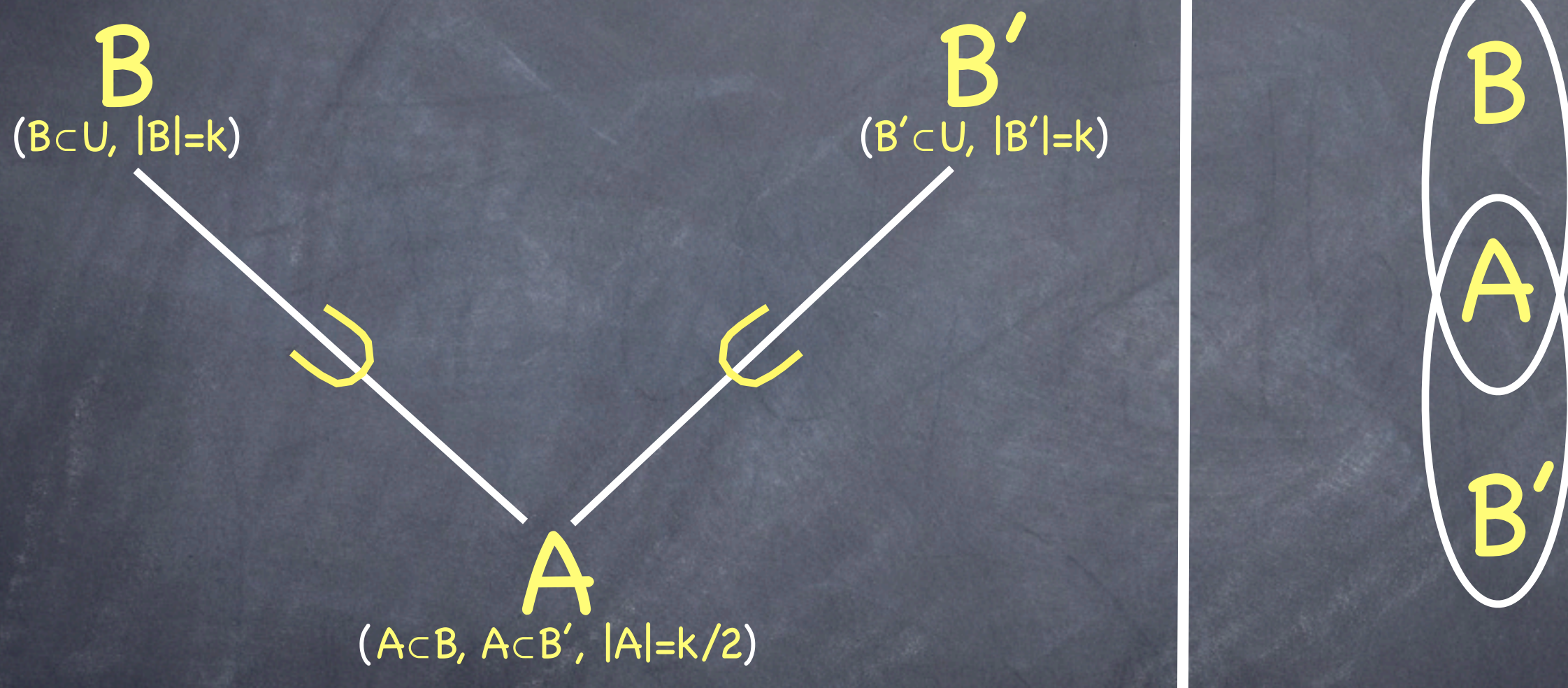


# Main Theorem

- Previous Theorem  $\Rightarrow$  Uniform DP Theorem
  - Repeat the algorithm  $O(1/\epsilon)$  times to produce a list of circuits.



# Local Consistency Test

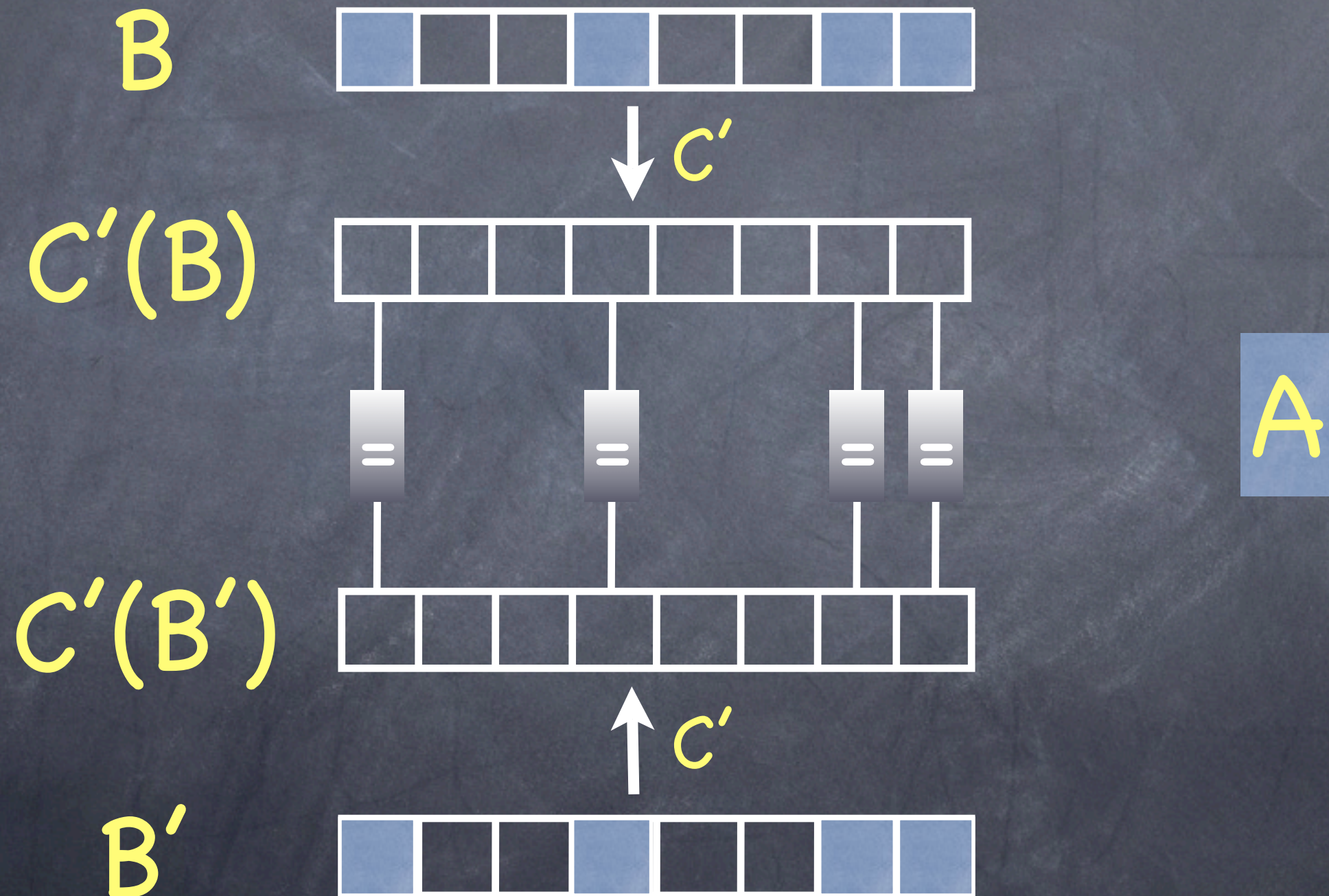


$B'$  is said to pass the consistency test wrt  $(A, B)$  if

$$C'(B)|_A = C'(B')|_A$$



# Local Consistency Test





# An Idea Based on Local Consistency Test

- Suppose there are sets  $A, B \supset A$  such that
  - $C'(B) = f^k(B)$
  - "some other nice properties"
- $C_{A,B}$ : Given an input  $x \in U$ 
  - If  $x \in B$ , then output  $C'(B)[x]$
  - Randomly select  $B'$ , such that  $A \subset B'$  and  $x \in B'$
  - If  $B'$  passes consistency test wrt  $(A, B)$ , then output  $C'(B')[x]$  else repeat



# When does $C_{A,B}$ work?

- Under what conditions does  $C_{A,B}$  work?
- Under what conditions “local consistency implies correctness”?
- What are the “nice properties”  $A,B$  need to satisfy?




# When does $C_{A,B}$ work?

• Under what conditions does  $C_{A,B}$  work?

(1)  $C'(B) = f^k(B)$

(2) There are non-negligible number of  $B' \supset A$   
s.t.  $C'(B') = f^k(B)$  and which pass the  
consistency test wrt.  $(A,B)$

(3) "Bad"  $B' \supset A$  fail the consistency test  
w.h.p.

$C'(B')$    $\neq f(.)$

• Let us call such  $(A,B)$  "excellent".



# Choosing Excellent $(A,B)$

- Choose  $A, B \supset A$  randomly
- Lemma:  $\Pr_{A, B \supset A}[(A, B) \text{ is excellent}] = \Omega(\epsilon)$



# Choosing Excellent $(A,B)$

(Proof:  $\Pr_{A,B \supset A}[(A,B) \text{ is excellent}] = \Omega(\varepsilon)$ )

- Recall (1)  $C'(B) = f^k(B)$
- Since  $\Pr_B[C'(B) = f^k(B)] > \varepsilon$ , randomly chosen  $A, B \supset A$  satisfies (1) with probability at least  $\varepsilon$ .
- We will try to show that (2) and (3) almost always follows from (1).



# Choosing Excellent $(A,B)$

(Proof:  $\Pr_{A,B \supset A}[(A,B) \text{ is excellent}] = \Omega(\epsilon)$ )

- Recall: (2) There are non-negligible number of  $B' \supset A$  s.t.  $C'(B') = f^k(B)$  and which pass the consistency test wrt.  $A, B$
- (2) almost always follows from (1):
  - Let  $P(A)$  be the event that  $\Pr_{B \supset A}[C'(B) = f^k(B)] \leq \epsilon/2$
  - $\Pr_{A,B \supset A}[C'(B) = f^k(B) \mid P(A)] \leq \epsilon/2$   
 $\Rightarrow \Pr_{A,B \supset A}[C'(B) = f^k(B) \ \& \ P(A)] \leq \epsilon/2$



# Choosing Excellent $(A,B)$

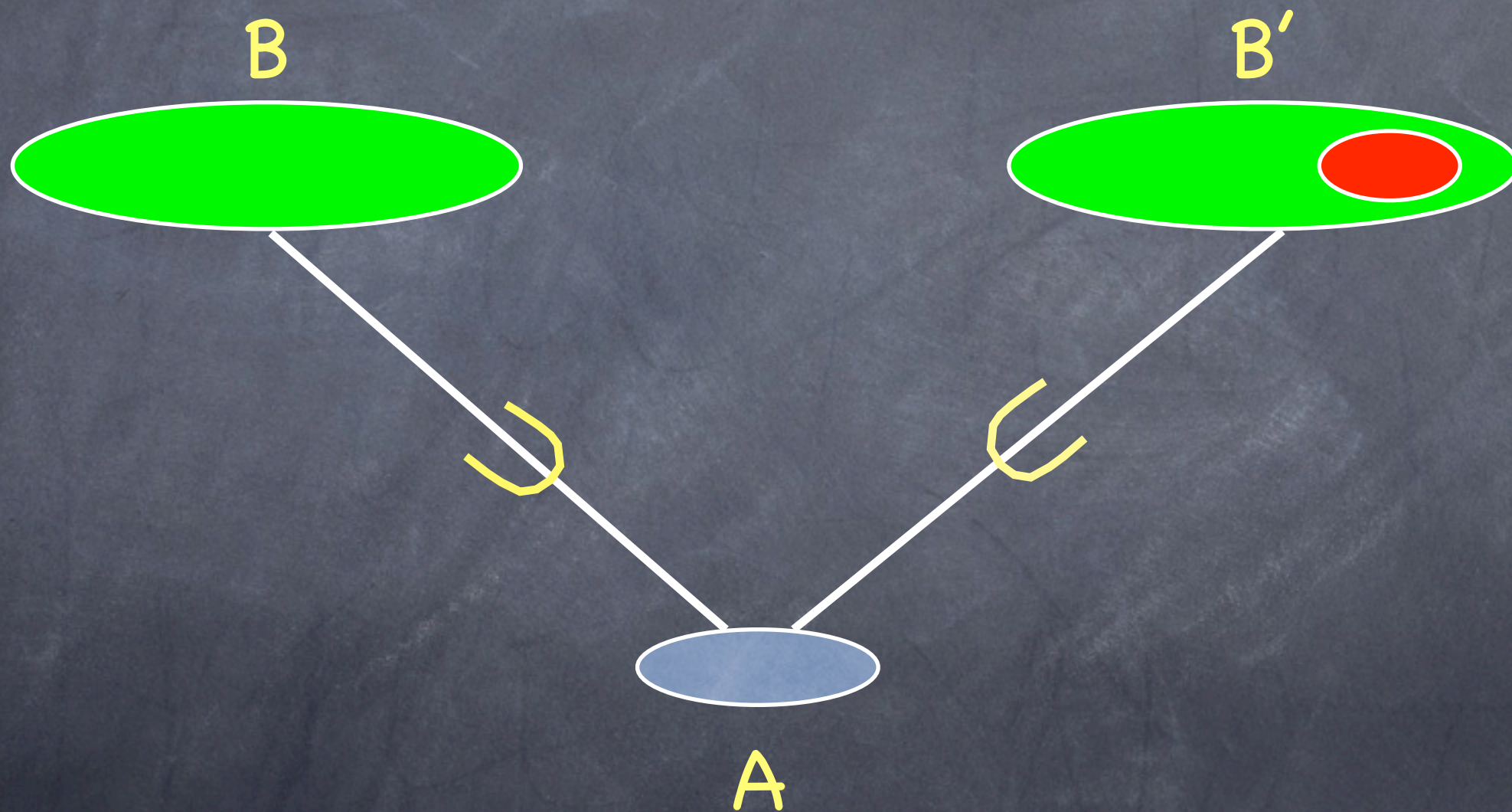
(Proof:  $\Pr_{A,B \supset A}[(A,B) \text{ is excellent}] = \Omega(\epsilon)$ )

- Recall: (3) “Bad”  $B' \supset A$  fail the consistency test w.h.p.
- (3) almost always follows from (1):
  - We want to show:  
 $\Pr_{A,B \supset A, B' \supset A}[C'(B)=f^k(B) \text{ \& } B' \text{ is “bad” \& } B' \text{ passes consistency test wrt } (A,B)]$   
is very small (say  $< \epsilon^3$ )



# Choosing Excellent $(A, B)$

(Proof:  $\Pr_{A, B \supset A}[(A, B) \text{ is excellent}] = \Omega(\epsilon)$ )



w.h.p  $A$  contains a "bad" element of  $B'$



# Where we are in the proof

- What we have shown:

- Lemma:  $\Pr_{A,B \supset A}[(A,B) \text{ is excellent}] = \Omega(\epsilon)$

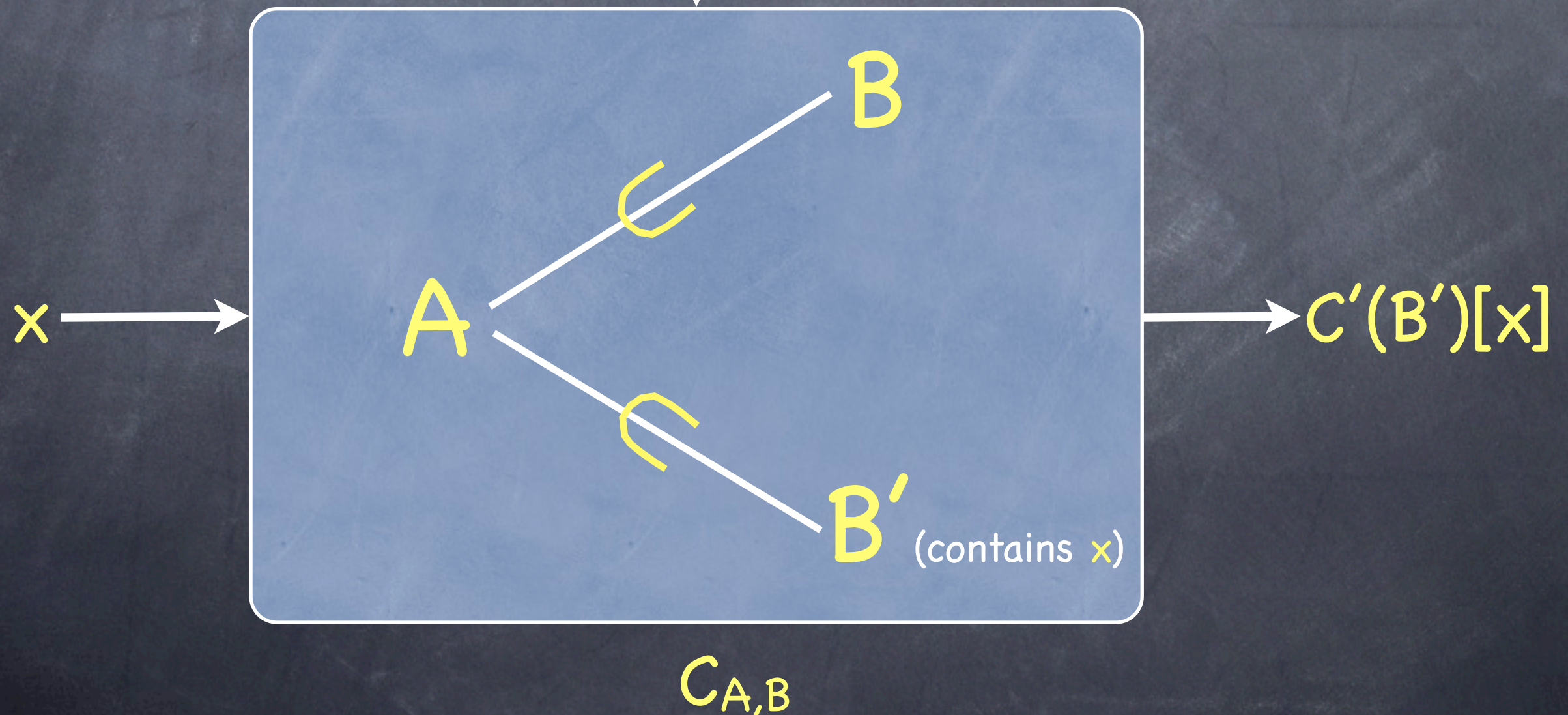
- What we need to show:

- Lemma: For any excellent  $(A,B)$ ,  $C_{A,B}$  computes  $f$  with probability at least  $(1-\delta)$



# Analyzing $C_{A,B}$ given excellent $(A,B)$

Algorithm randomly select  $A, B \supset A$



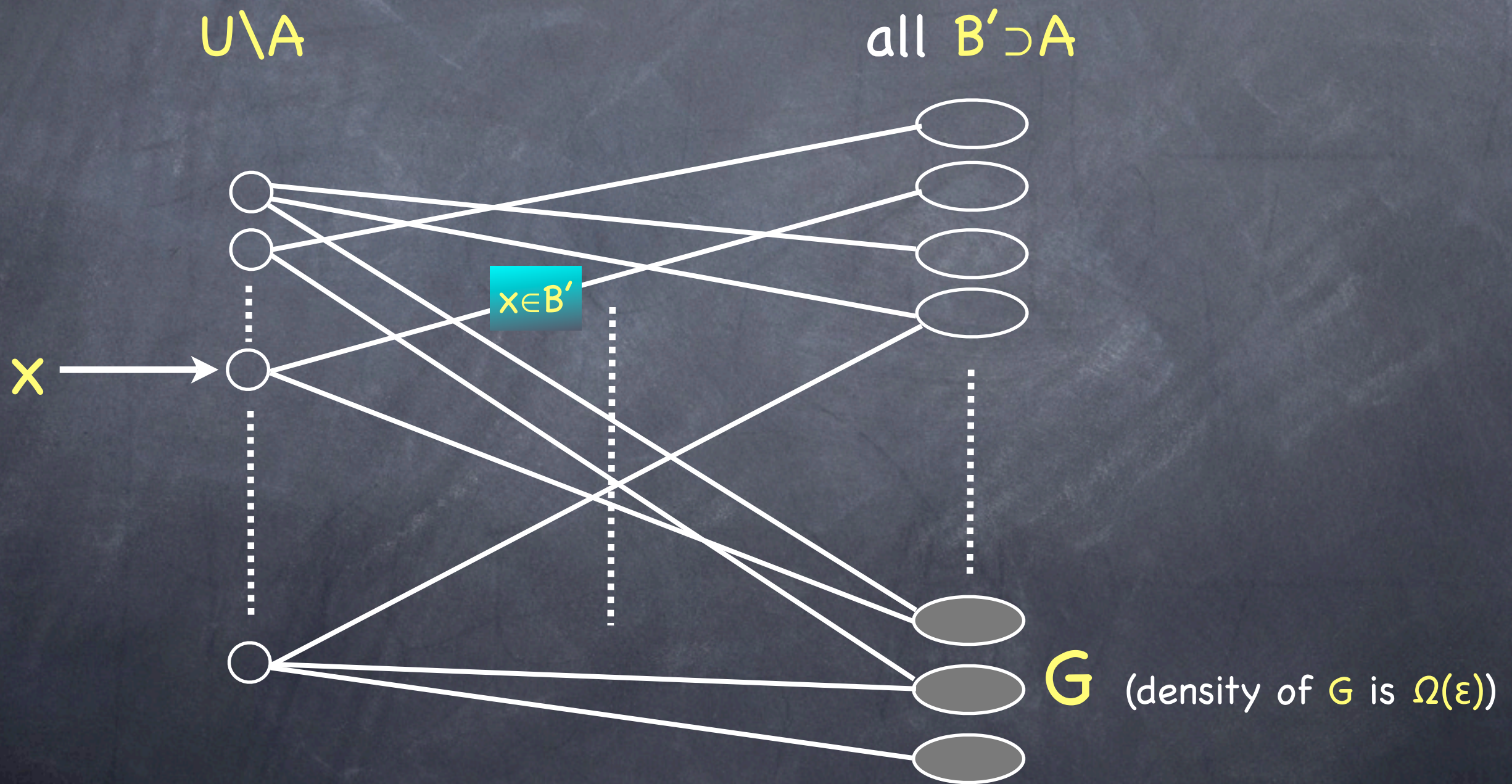


# Analyzing $C_{A,B}$ given excellent $(A,B)$

- $\Pr[C_{A,B} \text{ fails}] \leq \Pr[C_{A,B} \text{ does not output an answer}] + \Pr[C_{A,B} \text{ outputs an incorrect answer} \mid C_{A,B} \text{ outputs an answer}]$



# Analyzing $C_{A,B}$ given excellent $(A,B)$



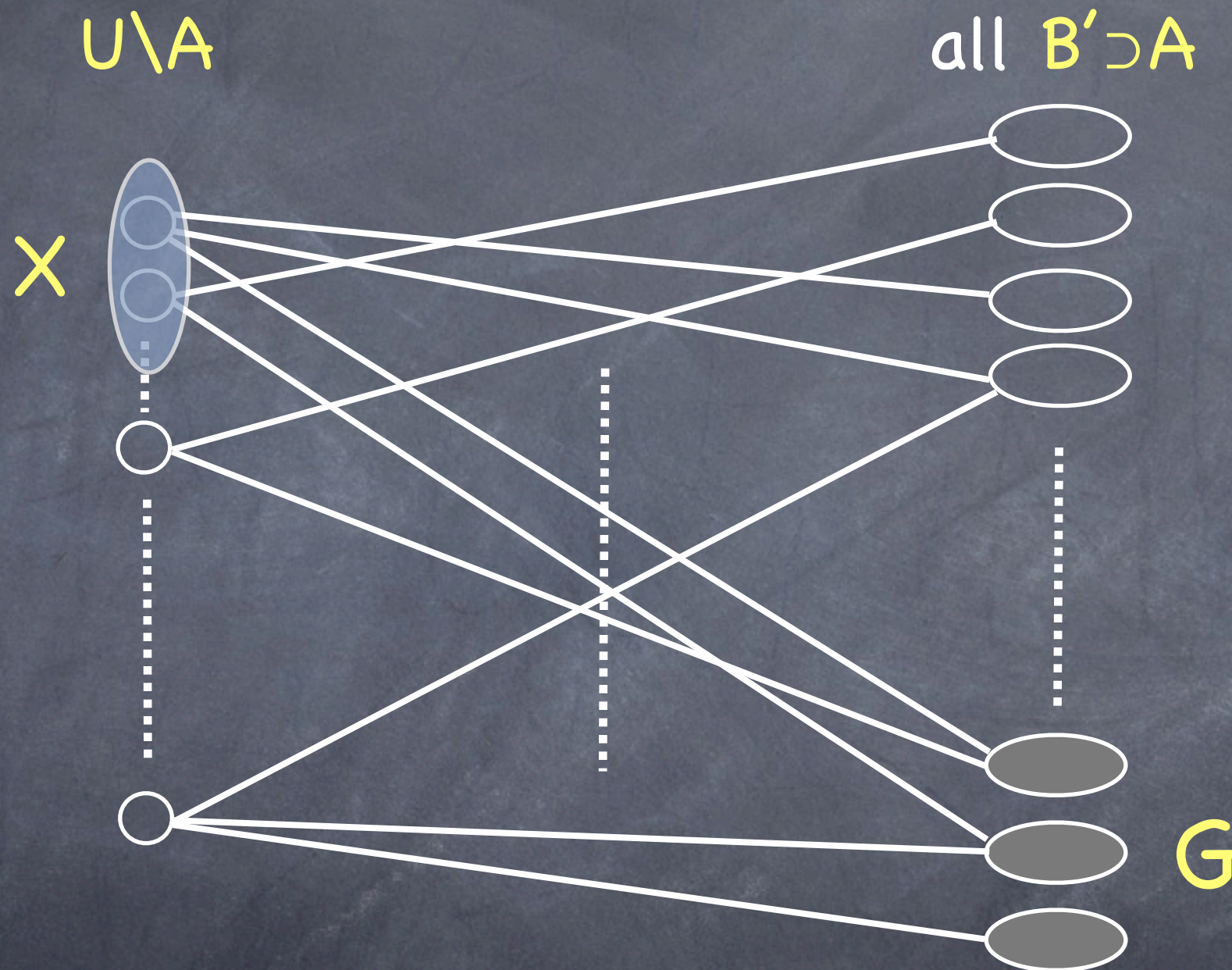


# Analyzing $C_{A,B}$ given excellent $(A,B)$

- $\Pr[C_{A,B} \text{ fails}] \leq \underbrace{\Pr[C_{A,B} \text{ does not output an answer}]}_{\text{Pr}[C_{A,B} \text{ outputs an incorrect answer} \mid C_{A,B} \text{ outputs an answer}]} + \Pr[C_{A,B} \text{ outputs an incorrect answer} \mid C_{A,B} \text{ outputs an answer}]$



# Analyzing $C_{A,B}$ given excellent $(A,B)$



Sampler: For any  $X \subset U \setminus A$  of density at least  $\beta$  almost all vertices in the right have at least  $\beta/2$  fraction of edges into  $X$ .



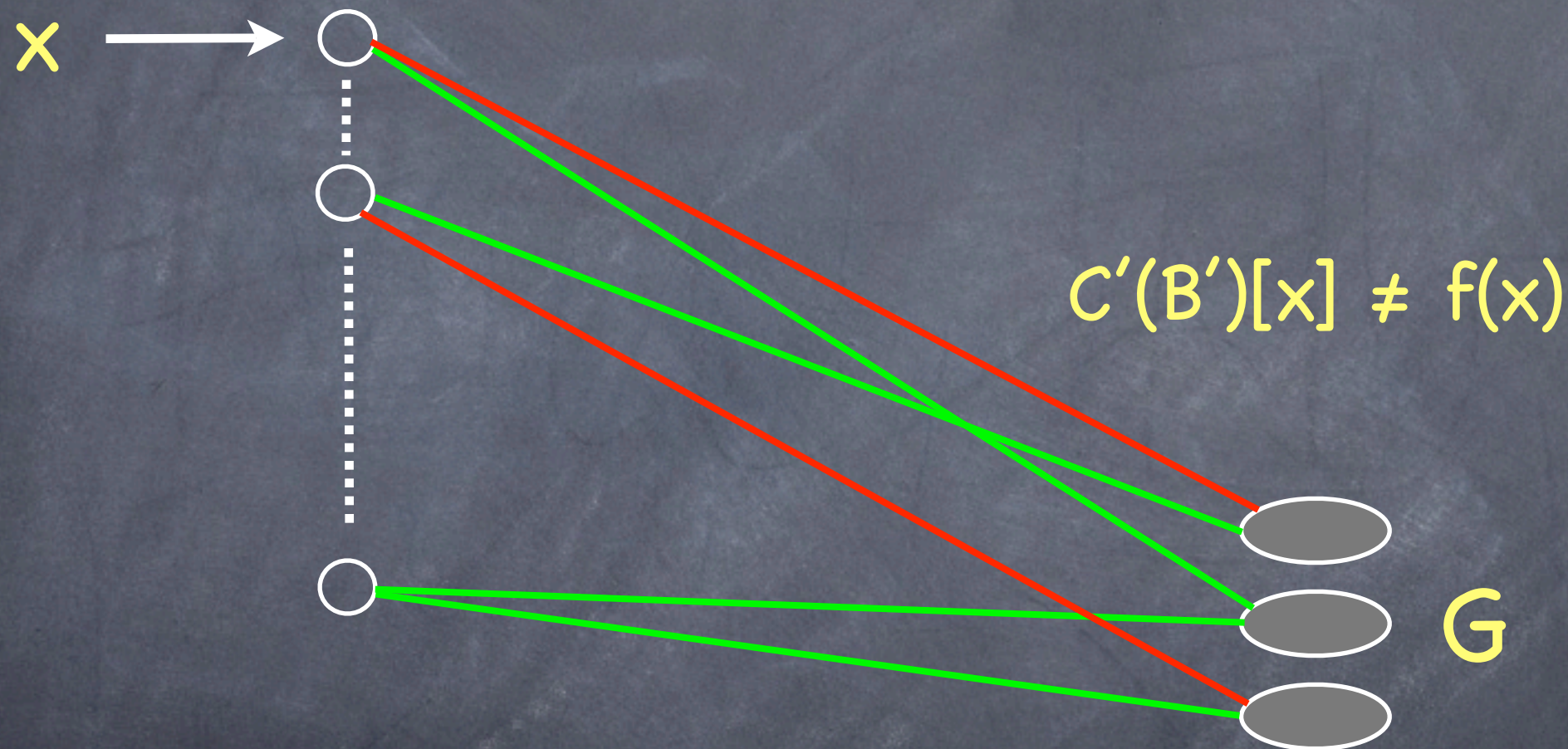
# Analyzing $C_{A,B}$ given excellent $(A,B)$

- $\Pr[C_{A,B} \text{ fails}] \leq \Pr[C_{A,B} \text{ does not output an answer}] + \Pr[C_{A,B} \text{ outputs an incorrect answer} \mid C_{A,B} \text{ outputs an answer}]$



# Analyzing $C_{A,B}$ given excellent $(A,B)$

$R_z = \frac{\text{\#red incident edges}}{\text{degree}}$



Want to bound  
 $E_x[R_x]$

We know that  
 $E_y[R_y]$  is small

Following holds for Samplers:  $E_x[R_x] \approx E_y[R_y]$



# Derandomized DP Theorem



# Derandomized DP Theorem

- DP Theorem: Given a hard  $f:U \rightarrow R$ ,  $f^k$  is harder to compute on independently chosen subsets  $B \subset U$ ,  $|B|=k$
- Issue: The size of the inputs grows linearly with  $k$

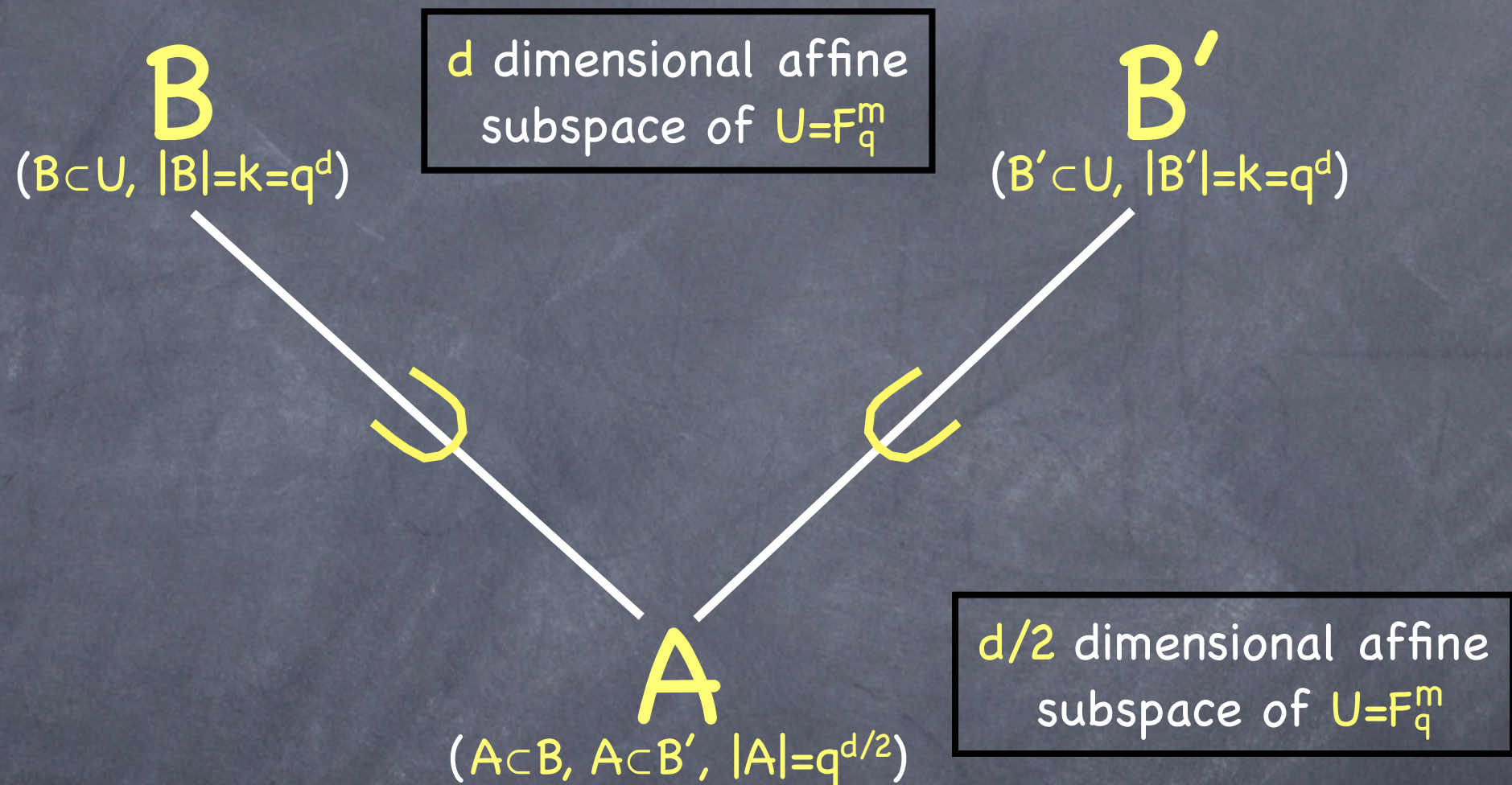


# Derandomized DP Theorem

- Derandomized DP Theorem: Can we show that  $f^k$  is harder to compute on subsets  $B \subset U$ ,  $|B|=k$ , even when these subsets have some limited independence
- [Imp95,IW97]: Derandomized DP Theorem in the nonuniform setting
- $U = F_q^m$ , and consider  $f^k$  over low dimensional affine subspaces of  $U$



# Local Consistency Test



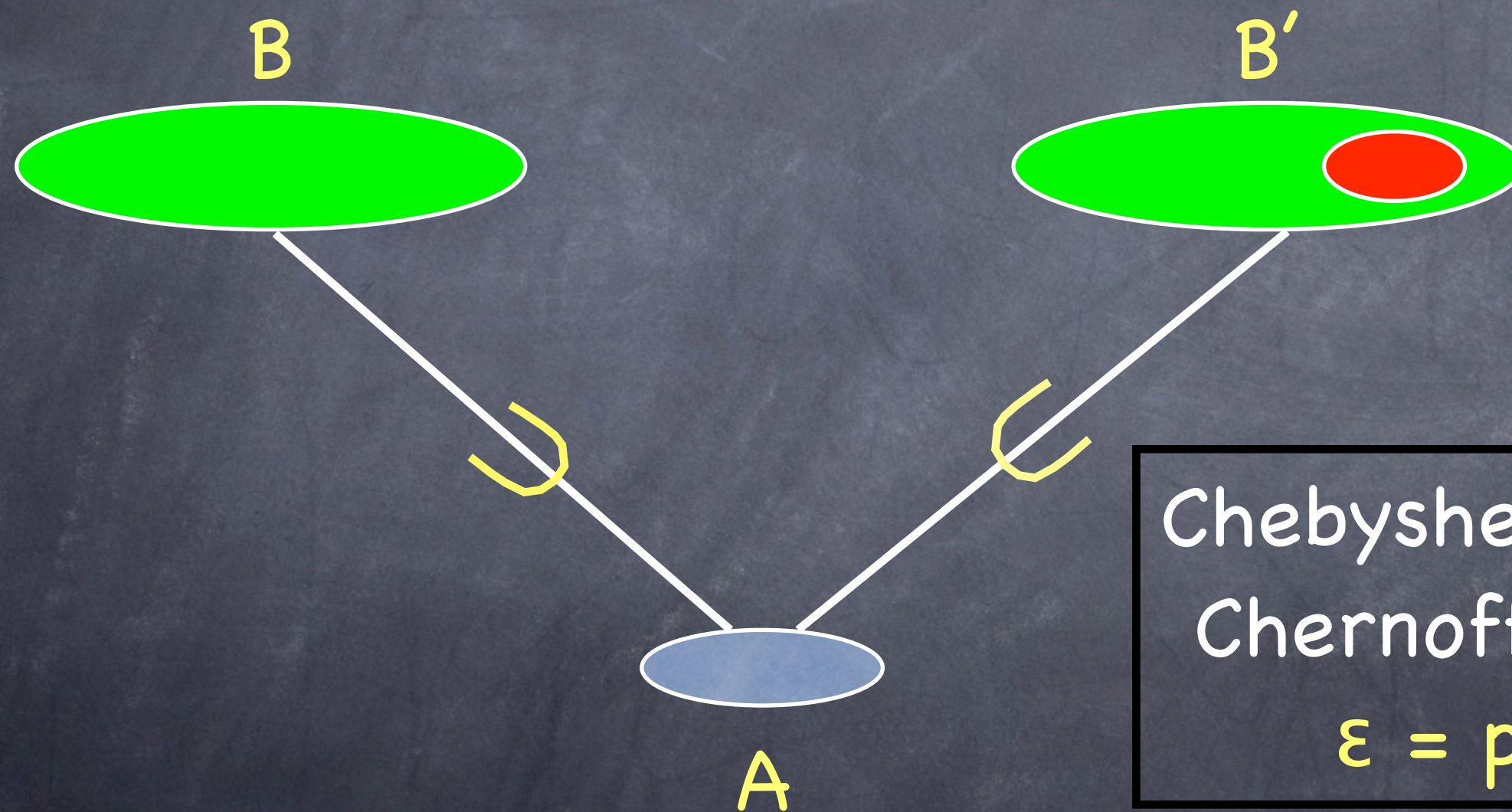
$B'$  is said to pass the consistency test wrt  $(A, B)$  if

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# Derandomized DP Theorem

(Proof:  $\Pr_{A,B \supset A}[(A,B) \text{ is excellent}] = \Omega(\varepsilon)$ )



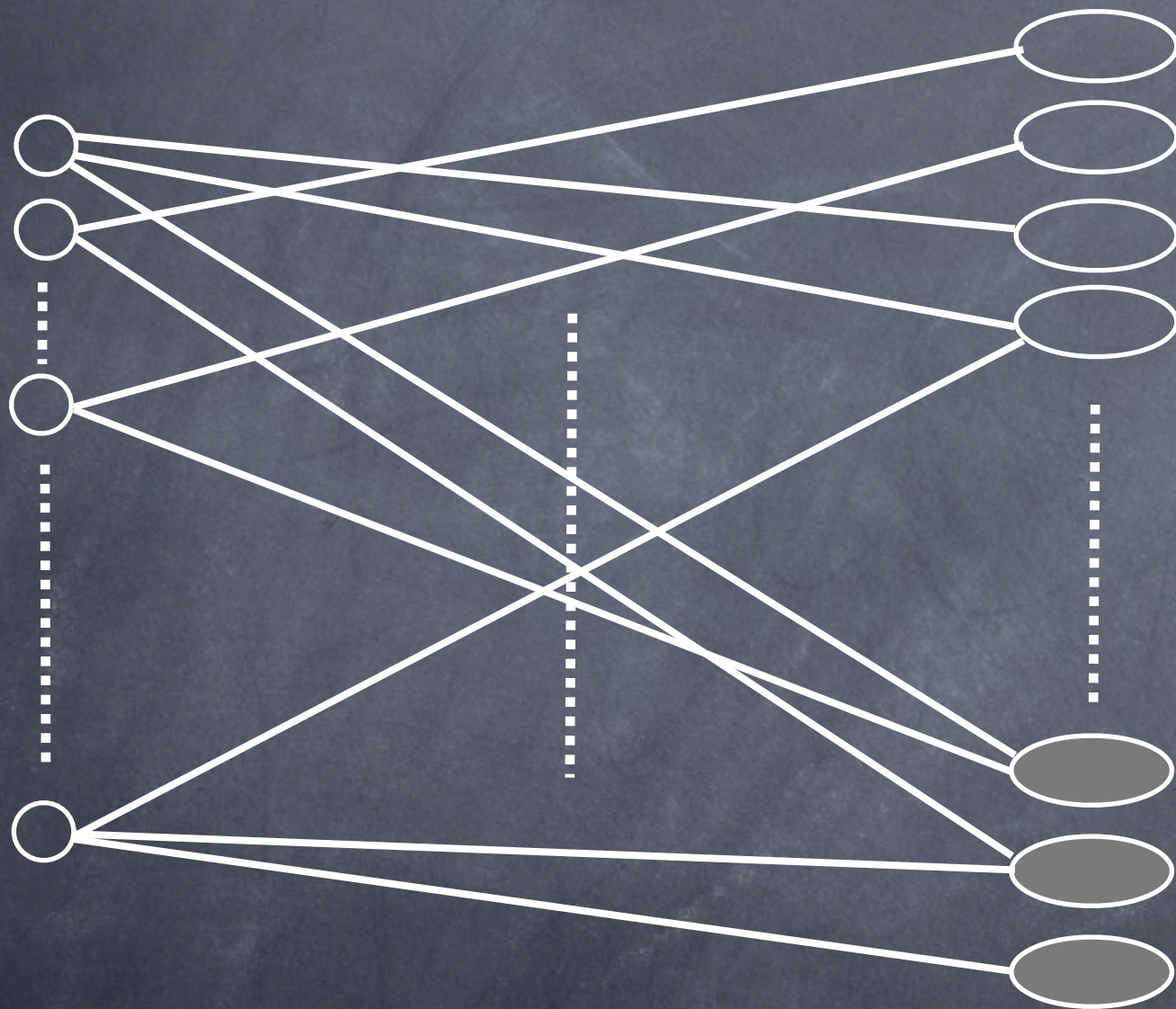
w.h.p  $A$  contains a "bad" element of  $B'$



# Derandomized DP Theorem

$U \setminus A$

all  $B' \supset A$



Chebyshev instead of  
Chernoff-Hoeffding  
 $\varepsilon = \text{poly}(1/k)$

Sampler: For any  $X \subset U \setminus A$  of density at least  $\beta$  almost all vertices in the right have at least  $\beta/2$  fraction of edges into  $X$ .

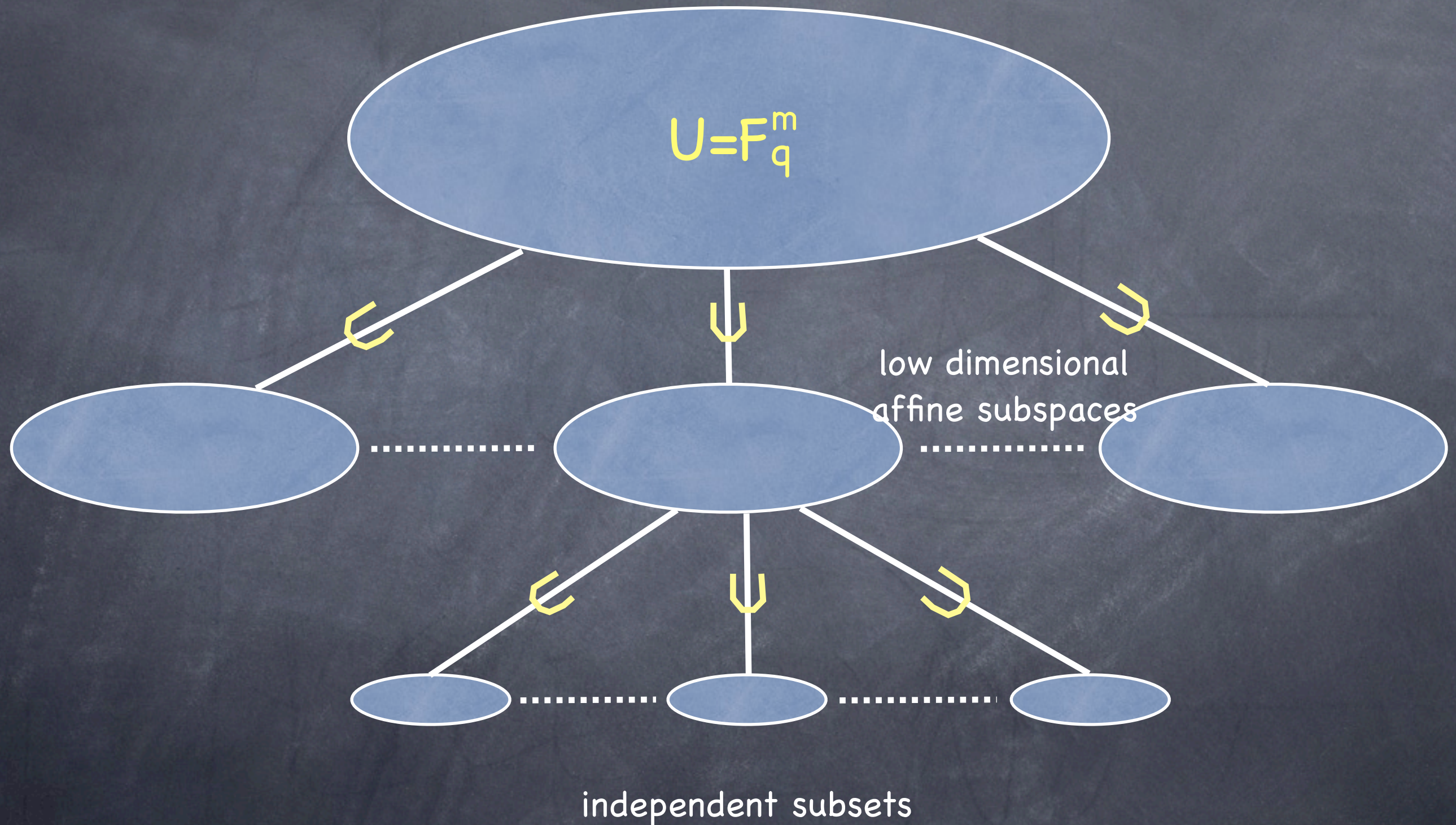


# Derandomized DP Theorem

- Theorem [IJKW08]: Let  $f:U \rightarrow R$  be some function and  $C'$  be a circuit such that  $\Pr_{\text{affine subspace } B \subset U}[C' \text{ computes } f^k(B)] > \varepsilon$ .  
There is an algorithm which outputs with probability  $\Omega(\varepsilon)$  a circuit  $C$  such that  $\Pr[C \text{ computes } f] > (1-\delta)$ ,  
where  $\varepsilon = \text{poly}(1/k)$ ,  $|C| = |C'| \cdot \text{poly}(1/\varepsilon, 1/\delta, k)$ .
- Note: description length of the input for  $f^k$  is  $d \cdot \log(|U|)$

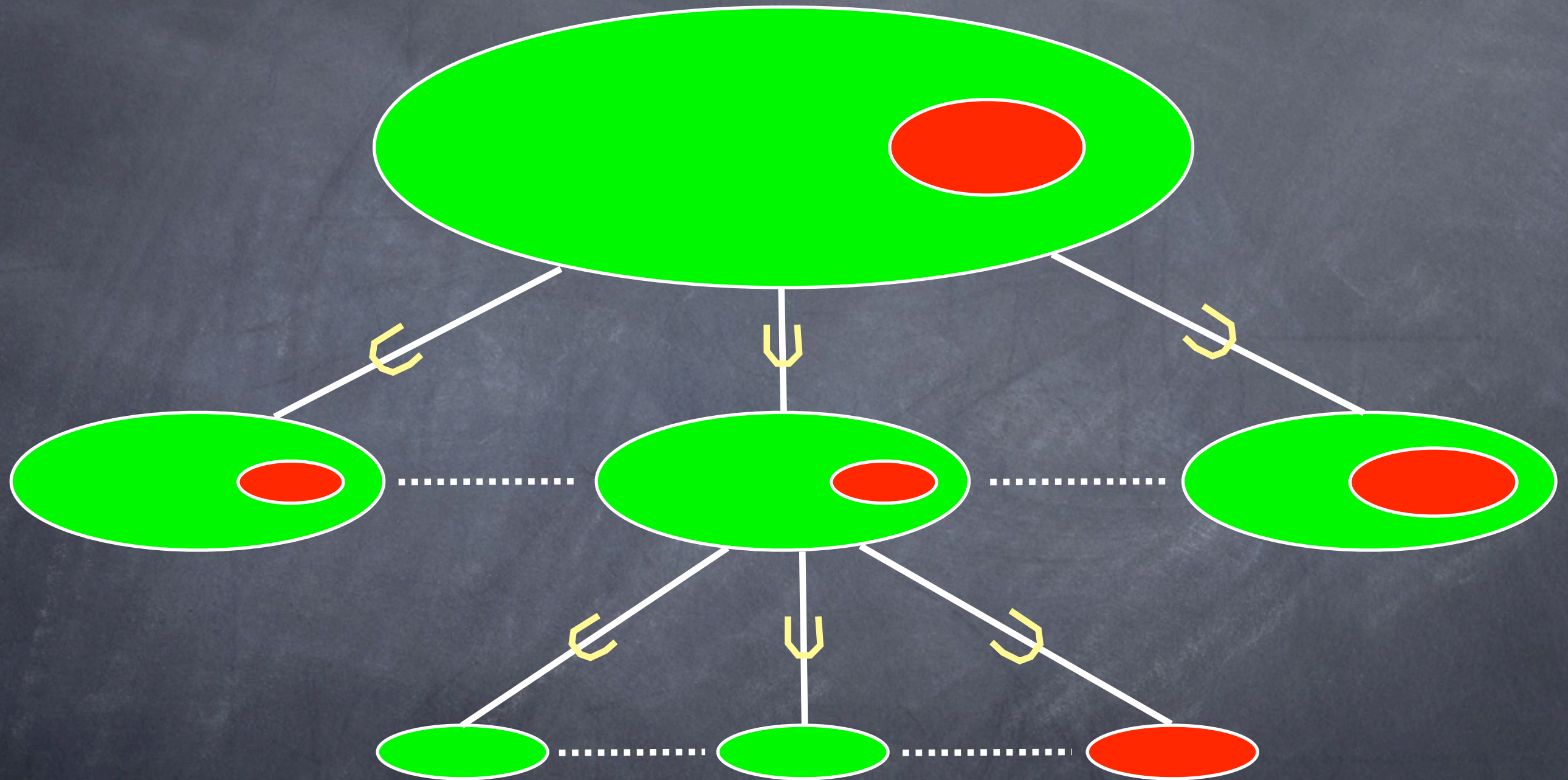


# Derandomized DP Theorem





# Derandomized DP Theorem



Approximate version of Derandomized  
DP Theorem



# Derandomized DP Theorem

- Theorem [IJKW08]: Let  $f:U \rightarrow R$  be some function and  $C'$  be a circuit such that  $\Pr_{\text{independent } B \subset T, \text{ low dim affine subspace } T \subset U} [C' \text{ computes } f^n(B)] > \epsilon$ .  
There is an algorithm which outputs with probability  $\text{poly}(\epsilon)$  a circuit  $C$  such that  $\Pr[C \text{ computes } f] > (1-\delta)$ ,  
where  $\epsilon = e^{-\Omega(\sqrt{n})}$ ,  $|C| = |C'| \cdot \text{poly}(1/\epsilon, 1/\delta, n)$ .
- Note: description length of input for  $f^k$  is  $O(n)$  (given  $\log(|U|=n)$ )
- Open Problem: Bring down  $\epsilon$  to  $e^{-\Omega(n)}$



# Open Problems

- Uniform “Chernoff-type” Direct Product Theorem in the spirit of [IJK07]
- Direct Product Testing
  - Given a circuit  $C$  as an oracle, using at most  $q$  queries to the oracle distinguish between the following two cases
    - $C$  computes  $f^k$  for some  $f$
    - $C$  computes  $f^k$  on only some small  $\epsilon$  fraction of inputs



Thank You